

# Analysis of short wavelength infrared radiation during laser welding of plastics

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Received 18 January 2018; revised 27 March 2018; accepted 3 April 2018; posted 3 April 2018 (Doc. ID 319859); published 0 MONTH 0000

In this paper, a new measurement system and a new approach in calculation for infrared (IR) radiation investigation in quasi-simultaneous transmission laser welding of plastics are presented. The measurement system is based on a MW/SWIR (medium-wave/short-wave IR) camera and optical filters narrowing the spectral region to SWIR. The measured signals contain radiation from the melted zone in between the semitransparent and absorbing polymers, as well as radiation from the surface and interior of the semitransparent polymer. The new calculation approach was developed to distinguish between these signals. It is based on simplification of the process to two places with two temperatures (surface and molten interface) and knowledge of the spectral optical properties of the material, filters, and camera response. The results of measurement and calculation for three different optical filters and polyoxymethylene samples with two thicknesses are shown and discussed. Good agreement is obtained for the calculation variant using normal transmissivity of the semitransparent polymer. ©2018 Optical Society of America

**OCIS codes:** (110.6820) Thermal imaging; (110.3080) Infrared imaging; (140.3390) Laser materials processing; (160.4760) Optical properties; (160.5470) Polymers; (150.5495) Process monitoring and control.

<https://doi.org/10.1364/AO.99.099999>

## 1. INTRODUCTION

Laser welding of plastics is well known in industry (e.g., automotive, electronics, and medical) for its advantages of being fast, versatile, reliable, and nondisturbing to sensitive components of parts [1]. It is also a promising way to connect polymer composites with long-fiber reinforcements [2], which seems to be a substitute for steel in some lightweight constructions in the automotive and aerospace industries. For laser welding of polymer composites, process control is necessary to ensure reliable and tight joints. To enable process control by short-wave infrared (SWIR) radiation, good understanding of the process is necessary.

Quasi-simultaneous transmission laser welding technology is based on a continuous laser with a scan head and a clamping system pressing two plastic materials together. The upper plastic is semitransparent to enable transmission of laser radiation to the lower plastic, which absorbs the radiation and is heated and melted. The upper plastic is heated by conduction from the lower plastic and then also melted. The melting is done on the interface between plastics only, so the surface of the upper plastic is only partly heated by heat conduction. After melting of both components and cooling down, the weld is produced. The laser beam moves fast and many times on the welding contour during the process, which enables melting of the material on all

places simultaneously. Under applied pressure, the melt flows out of the contact region, and the samples move toward each other. This movement is called a set path and is measured by contact distance measurement [1].

Understanding of the IR radiation sources (molten interface and upper semitransparent plastic) during welding and their spectral and spatial distribution enables deeper understanding of the welding process and increases the possibilities of its quality control in production. IR radiation emitted from the molten interface is partly transmitted through the upper semitransparent plastic and partly absorbed, depending on wavelength, thickness, and optionally, glass fiber content for composites. IR radiation from the upper plastic at a lower temperature (different temperatures at different depths) is emitted either near its surface without attenuation or emitted at bigger depth and partly transmitted through some part of it.

A long-wave infrared (LWIR, 7.5–14  $\mu\text{m}$ ) or medium-wave infrared (MWIR, 3.4–5  $\mu\text{m}$ ) camera was used to analyze the welding process and possibly can be used for quality monitoring or even process control in a production line [1,3–6]. For these wavelengths, the plastics used are usually opaque and surface temperature of the upper plastic is measured.

A pyrometer sensitive at SWIR (1.65–2.1  $\mu\text{m}$ ), combined with a scan head, was tested in laser transmission welding in contour and quasi-simultaneous configurations [7,8]. It was

found that SWIR wavelengths are interesting for quality control of laser transmission welding, because for these wavelengths the plastics used are semitransparent, and information about temperature at the molten interface can be obtained. However, only pyrometers have been used up to now. In the present study, we use an IR camera at SWIR wavelengths. Use of an IR camera is simpler for industrial application than using a pyrometer, because the combination of pyrometer with a scan head is complicated. Incorporation of the pyrometer into the scan head needs special optics to have the spot always in the same place [9]. An IR camera can easily also investigate other places besides the current laser position.

Laser welding of long-fiber reinforced thermoplastics was studied by an MWIR IR camera [2]. Surface temperatures were measured for different combinations of fiber orientation and laser movement trajectory. A study on long-fiber reinforced thermoplastics [9] with an SWIR pyrometer placed in different positions relative to the laser spot was done. The goal of development was a combined scan head for scanning laser and pyrometer independently, which would also enable control of laser power during welding for curved weld seams or sharp corners.

The optical properties of polypropylene (PP), polycarbonate (PC), and polyamide (PA) for laser transmission welding were investigated in [10] for pure polymers and for polymer composites with short glass fibers. The spectral dependence of scattering and absorbance was measured in a wavelength range from 0.25 to 2.5  $\mu\text{m}$  from comparison of normal and hemispherical configuration signals. The scattering changed significantly with the wavelength, sample thickness, and glass fiber content.

Measurement by pyrometer (sensitive from 1.1 to 2.1  $\mu\text{m}$ ) in a pulsed mode of welding is proposed in [11] for overcoming saturation by laser radiation on the same wavelength (1.68  $\mu\text{m}$ ) during transmission welding without an absorber. Measurement is done in the laser-off period. The experimental method and numerical model for a semitransparent material temperature measurement/calculation using one channel IR pyrometer are described in [12].

Different numerical modeling techniques were applied for prediction of temperatures at different locations during the transmission laser welding process [3,6,13–16], but none of them was developed to predict IR radiation from the interface during the welding process.

The purpose of the present work is to understand more clearly the importance of different optical properties on the measurement of IR radiation and the importance of the sources of IR radiation (molten interface and surface) during quasi-simultaneous transmission laser welding of plastics. The goal of this work is to contribute to a future precise temperature measurement of the molten interface between plastics during welding and thus enable the process monitoring and control for reliable industrial production. The spectral transmissivity and reflectivity of polymers were measured in a wide range of IR wavelengths in normal and hemispherical configurations. The spectral emissivity was determined from them. It was introduced to evaluate its influence on the final signal. The transmissivity of optical filters was also measured. The new

calculation method for the IR radiation signal is presented based on the knowledge of optical properties. The results of calculation are compared to the results of measurement for better understanding of the IR radiation emitted during the welding process.

## 2. EXPERIMENT

In this section, details of the experimental system for laser welding of plastics with an IR camera measurement system and optical properties measurements are presented.

### A. Laser Welding with IR Camera Measurement

The laser welding system consisted of a 300 W fiber laser (IPG YLR-300/3000-QCW-MM-AC, wavelength 1070 nm) with a scan head (Scanlab intelliSCAN 20, objective EFL = 500 mm) and a pneumatic clamping system with distance and force measurement (Fig. 1). The welding process was quasi-simultaneous transmission laser welding with laser beam speed 5  $\text{m} \cdot \text{s}^{-1}$ , spot diameter 1 mm, laser power 36 W (1 mm thick sample), and 63 W (2 mm thick), clamping force 87 N, and welding time 5.3 s. The different laser powers are necessary to produce good welds to obtain approximately the same temperatures at the interface. For the thicker semitransparent polymer, the laser power has to be higher due to the lower transmissivity of this polymer. The samples were composed of semitransparent and absorbing polymers. The semitransparent polymer was 1 and 2 mm thick polyoxymethylene plate (POM-C nature) with size 25 mm  $\times$  50 mm. The absorbing polymer was 2 mm thick POM plate with carbon black (POM-C black) with size 25 mm  $\times$  40 mm. The melting temperature of both polymers was 165°C. The welding configuration was a T-joint. The laser beam was scanned on two parallel lines 1 mm apart to fill the 2 mm wide band of the absorbing polymer side. The length of the weld seam was 40 mm. The combination of the welding parameters (force, time, laser power) resulted in a set path (vertical sample movement during melting) bigger than 300  $\mu\text{m}$ .

The IR measurement system consisted of two IR cameras (LWIR and MW/SWIR) and an optical filter in front of the MW/SWIR camera. The measurement system was mounted on the laser welding system (Fig. 1). The angle between the sample surface normal and the camera was 32° for the

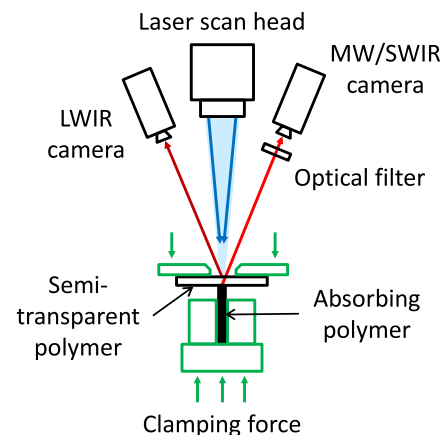


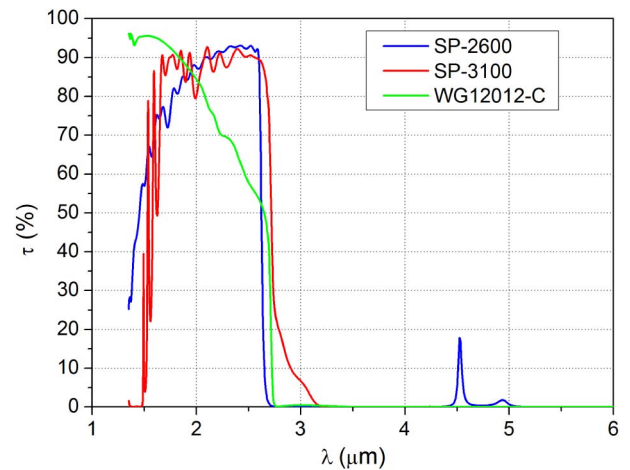
Fig. 1. Schematic representation of the experimental system.

166 LWIR camera and 22° for the MW/SWIR camera. The LWIR  
 167 camera (FLIR A615), sensitive in the wavelength range from  
 168 7.5 to 14  $\mu\text{m}$ , was used to measure the surface temperature  
 169 of the semitransparent polymer. At these wavelengths, the  
 170 POM polymer is opaque; the measured hemispherical  
 171 transmissivity was about 0.1% for the 1 mm thick sample  
 172 and smaller than 0.05% for the 2 mm thick sample. For  
 173 the LWIR camera, a frame rate of 12.5 Hz and temperature  
 174 range of  $-40^\circ\text{C}$  to  $+150^\circ\text{C}$  was used. The MW/SWIR camera  
 175 (FLIR SC7650), sensitive in the wavelength range  $\lambda$  from 1.1 to  
 176 6.0  $\mu\text{m}$ , was used to study IR radiation from the heated and  
 177 melted interface during laser welding. This camera is cooled by  
 178 a Stirling engine to very low temperatures and has high sensi-  
 179 tivity and the possibility of measuring at high frequencies. Most  
 180 of the measurements were done at frequency 870 Hz and inte-  
 181 gration time 1.2 ms. The camera was calibrated using a black-  
 182 body to investigate the dependency of the signal on integration  
 183 time settings, and linear dependence was found. So, for other  
 184 integration times used (0.2 and 0.6 ms), the signals were multi-  
 185 plied (by 6 and 2) to obtain the signal at integration time  
 186 1.2 ms. The lower and upper temperature limit (actual temper-  
 187 ature range) depends on the integration time used for this  
 188 camera. For 1.2 ms, it was  $5^\circ\text{C}$  to  $50^\circ\text{C}$ . The results are shown  
 189 in a.u. (counts) because the measurement is done through the  
 190 semitransparent polymer, and the values in temperature units  
 191 **2** ( $^\circ\text{C}$ ) are not valid.

192 Three different optical filters were used to limit the spectral  
 193 sensitivity of the MW/SWIR camera to the SWIR range. This  
 194 was done in order to enable measurement of IR radiation from  
 195 the melted interface between the two polymers and decrease of  
 196 radiation from the surface. The interface has a higher temper-  
 197 ature compared to the surface, and so its radiation is shifted to  
 198 shorter wavelengths. The filters SP-2600 and SP-3100  
 199 (Spectrogon) were shortpass filters with diameter 25.4 mm  
 200 and thickness 0.5 mm. Their spectral transmissivity depend-  
 201 ence is based on optical coatings. The filter WG12012-C  
 202 (Thorlabs) was an N-BK7 glass optical window with diameter  
 203 50.8 mm and thickness 12 mm with an anti-reflection (AR)  
 204 coating for wavelengths 1050–1700 nm. Its spectral transmis-  
 205 sivity dependence is based mainly on the glass material and its  
 206 thickness. The filter SP-2600 has significant transmission at  
 207 about 4.5  $\mu\text{m}$  wavelength, which was not known when it  
 208 was acquired, but it is important for the camera signal.

### 209 B. Optical Properties Measurement

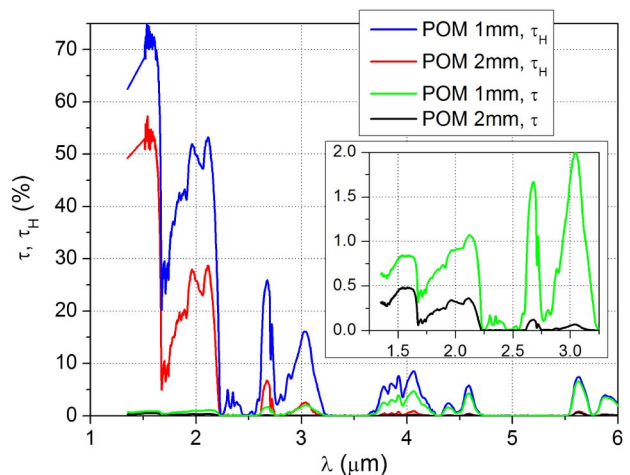
210 Optical properties of samples and filters were measured for use  
 211 in the calculation of IR radiation for understanding of the mea-  
 212 sured IR radiation signal from the welding process. The spectral  
 213 normal transmissivity  $\tau$  (denoted later “normal transmissivity”)  
 214 of optical filters and POM samples were measured by an FTIR  
 215 **3** spectrometer with a normal transmission accessory. The spec-  
 216 tral normal hemispherical transmissivity  $\tau_H$  and reflectivity  $\rho_H$   
 217 (denoted later “hemispherical transmissivity and reflectivity”)  
 218 of POM samples were measured by an FTIR spectrometer  
 219 (Nicolet 6700, incidence angle  $12^\circ$ ) and UV-VIS-NIR disper-  
 220 sive spectrometer (Analytik Jena, Specord 210 BU, incidence  
 221 angle  $8^\circ$ ) using the integration sphere accessory and calibrated  
 222 reference standards [17]. The hemispherical transmissivity and  
 223 reflectivity values in the range from 1.1 to 1.5  $\mu\text{m}$  were



**Fig. 2.** Measured spectral normal transmissivity of the optical filters.

224 interpolated from the measurements on two spectrometers  
 225 (FTIR and UV-VIS-NIR). Normal and hemispherical trans-  
 226 missivity values were measured for the calculation for compari-  
 227 son with measurement in order to understand which of these  
 228 quantities is more relevant for the IR radiation measurement.  
 229 The emissivity was measured in order to assess its influence in  
 230 the resulting IR signal.

231 The measured spectral normal transmissivity of the filters is  
 232 shown in Fig. 2. The spectral optical properties of semitrans-  
 233 parent samples are shown in Figs. 3 and 4. Hemispherical trans-  
 234 missivity and reflectivity account for light going in all direc-  
 235 tions after transmission or reflection by the sample. Normal trans-  
 236 missivity accounts only for light going in the same direction  
 237 as the original light beam. As can be seen from Fig. 3, the  
 238 POM material is significantly scattering light at short wave-  
 239 lengths of IR. The normal transmissivity is only 0.9% for  
 240 the 1 mm thick sample at 2  $\mu\text{m}$  wavelength, compared to  
 241 50% for hemispherical transmissivity. At middle-wave IR,  
 242 the scattering is much lower. The normal transmissivity is  
 243 4.3% for the 1 mm thick sample at 4.6  $\mu\text{m}$  wavelength,  
 244 compared to 5.8% for hemispherical transmissivity.



**Fig. 3.** Measured spectral normal and hemispherical transmissivity of natural (semitransparent) POM samples.

245 Spectral emissivity  $\varepsilon$  was calculated from hemispherical  
246 transmissivity  $\tau_H$  and hemispherical reflectivity  $\rho_H$  by  
247 Kirchhoff's law:

$$\varepsilon = 1 - \tau_H - \rho_H. \quad (1)$$

### 248 3. CALCULATION

249 The calculation approach for IR radiation is schematically rep-  
250 resented in Fig. 5. The radiation from the laser welding process  
251 is simplified to radiation from two sources with two temper-  
252 atures: upper surface of the semitransparent polymer and  
253 molten interface (upper surface of the absorbing polymer).  
254 The radiation from both sources goes to the MW/SWIR  
255 camera and produces together one measurement signal.

256 The interface between the two polymers is melted during  
257 the welding process. The melting temperature of the POM  
258 material was determined by differential scanning calorimetry  
259 (DSC) to 165°C. The degradation of the POM material starts  
260 at about 230°C [1]. The temperature of the molten interface  
261  $T_{int}$  was set in the middle of the two temperatures to 200°C in  
262 the calculation. The thermal radiation emitted from the inter-  
263 face is described by Planck's law as spectral radiation intensity  
264  $L_{int}(T_{int}, \lambda)$  at given wavelength  $\lambda$  and interface temperature  
265  $T_{int}$ . The signal measured by the MW/SWIR camera from  
266 molten interface  $S_{int}$  is in the calculation given by the equation,

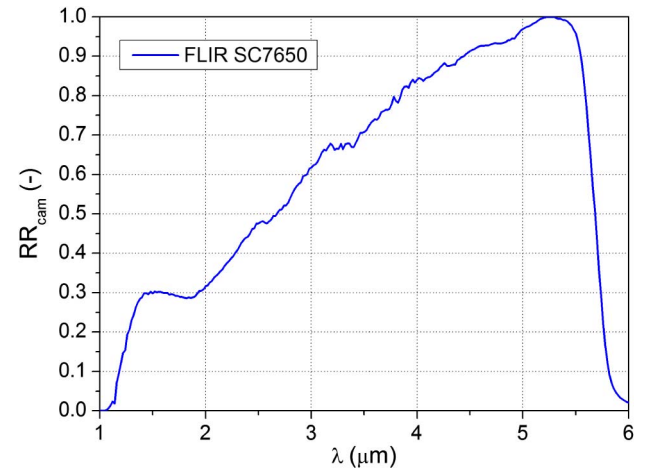


Fig. 6. Relative spectral response of the MW/SWIR camera.

F6:1

$$S_{int} = \int_{\lambda_1}^{\lambda_2} L_{int}(T_{int}, \lambda) \cdot \varepsilon_{int} \cdot \tau_{pol}(\lambda) \cdot \tau_{fil}(\lambda) \cdot RR_{cam}(\lambda) \cdot d\lambda, \quad (2)$$

267 where  $\varepsilon_{int}$  is the spectral emissivity of the absorbing polymer  
268 sample,  $\tau_{pol}$  is the spectral transmissivity of the semitransparent  
269 polymer sample,  $\tau_{fil}$  is the spectral transmissivity of the optical  
270 filter, and  $RR_{cam}$  is the relative spectral response of the MW/  
271 SWIR camera. The relative response  $RR_{cam}$  of the MW/SWIR  
272 camera is shown in Fig. 6 (data obtained from camera supplier).  
273 The integration is done numerically with step 10 nm, and  
274 limits of integration are given by the spectral sensitivity of  
275 the camera and Planck's law signal:  $\lambda_1 = 1.35 \mu\text{m}$  and  
276  $\lambda_2 = 6.00 \mu\text{m}$ . For the sample transmissivity  $\tau_{pol}$ , either hemi-  
277 spherical or normal transmissivity is used in the calculation.  
278 The emissivity of the interface  $\varepsilon_{int}$  is assumed to be equal to  
279 1, because the absorbing polymer is filled with carbon and  
280 has very high emissivity.

281 The thermal radiation emitted from the surface is described  
282 by Planck's law as spectral radiation intensity  $L_{sur}(T_{sur}, \lambda)$   
283 at given wavelength  $\lambda$  and surface temperature  $T_{sur}$ . The signal  
284 measured by the MW/SWIR camera from surface  $S_{sur}$  is in  
285 the calculation given by the equation

$$S_{sur} = \int_{\lambda_1}^{\lambda_2} L_{sur}(T_{sur}, \lambda) \cdot \varepsilon_{sur} \cdot \tau_{fil}(\lambda) \cdot RR_{cam}(\lambda) \cdot d\lambda. \quad (3)$$

286 The emissivity of the semitransparent polymer  $\varepsilon_{sur}$  is, in the  
287 first stage, assumed to be equal to 1, and in the second stage, the  
288 spectral value calculated from the measured transmissivity and  
289 reflectivity of the sample is used.

290 The IR signal measured by the MW/SWIR camera during  
291 the welding process  $S_{IR}$  is in the calculation given by

$$S_{IR} = S_{int} + S_{sur}. \quad (4)$$

292 The calculation was done in two variants (see Table 1) in  
293 order to investigate the influence of optical properties on the  
294 agreement of the calculation with the experiment. In the first  
295 variant, the hemispherical transmissivity of the semitransparent  
296 polymer was used, and its emissivity was assumed to be equal to  
297 1. In the second variant, normal transmissivity was used to

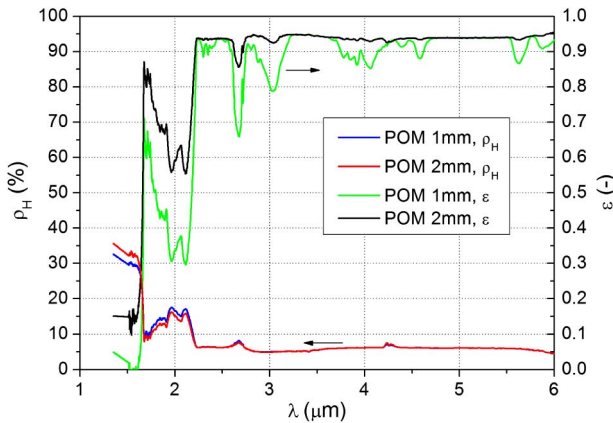


Fig. 4. Measured spectral hemispherical reflectivity and calculated emissivity of natural POM samples.

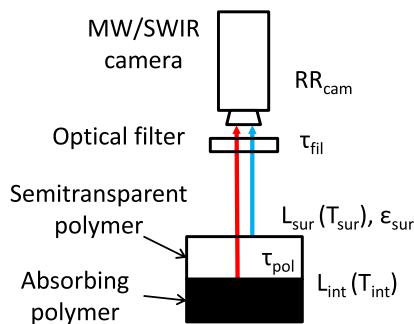
F4:1  
F4:2

Fig. 5. Schematic representation of the SWIR measurement system for the purpose of calculation.

F5:1  
F5:2

**Table 1. Variants of Calculation of the IR Radiation Signal**

Variant	Transmissivity of Semitransparent Sample	Emissivity of Semitransparent Sample
1	hemispherical	=1
2	normal	as measured

T1:1  
T1:2  
T1:3

298 evaluate which type of transmissivity is valid for the IR camera  
299 temperature measurement, and the measured emissivity of the  
300 semitransparent polymer was introduced to evaluate its influ-  
301 ence on the final signal. The transmissivity of the semitranspar-  
302 ent polymer in the calculation affects only the interface signal,  
303 and the emissivity of semitransparent polymer affects only the  
304 surface signal. It is because  $\tau_{pol}$  is present only in Eq. (2) and  
305  $\epsilon_{sur}$  is present only in Eq. (3).

**306 4. RESULTS**

307 In this section, the results of the measurement and calculation  
308 of IR radiation from the laser welding of plastics are presented.

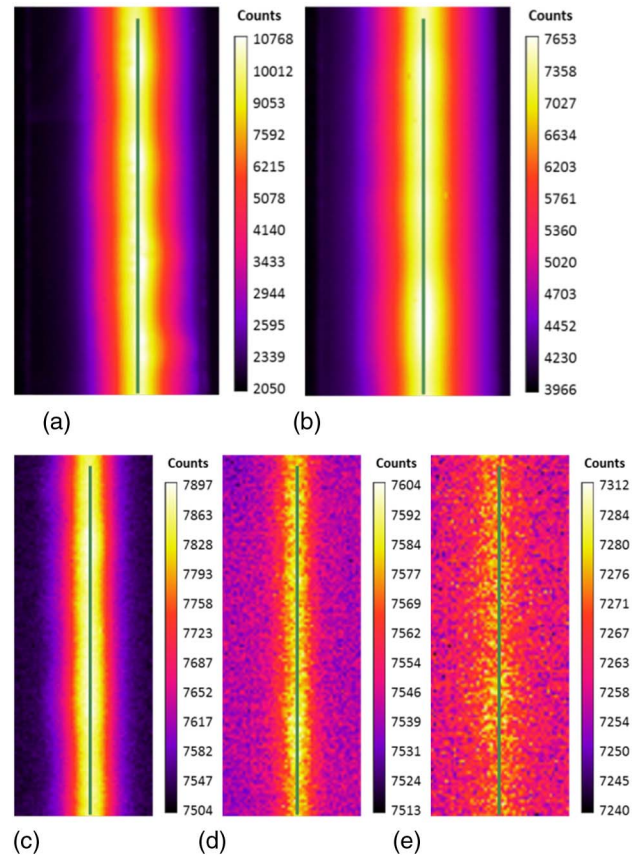
**309 A. Experimental Results**

310 Examples of measured thermal images from the MW/SWIR  
311 camera are shown in Fig. 7. These images are without a filter  
312 for two thicknesses of the semitransparent sample (POM 1 and  
313 2 mm) and with filters for the 1 mm thickness. For measure-  
314 ment without a filter, there is enough signal, and shorter inte-  
315 gration times are used. For measurement with filters, the  
316 images are noisy even with longer integration time. The IR  
317 signal used for investigations was extracted as an average from  
318 signals of pixels in line L1 placed along the welding line in its  
319 center.

320 The signal distribution in distance from the welding line is  
321 different for different thicknesses [Figs. 7(a) and 7(b)]. For the  
322 thicker sample, the signal is more widely distributed. This can  
323 be caused by scattering of radiation inside the sample or by 3D  
324 heat conduction (compared to more 1D conduction in a  
325 thinner sample).

326 The IR signal evolutions over time measured without a filter  
327 are shown in Fig. 8 for two sample thicknesses. The signal rises  
328 more than linearly during laser heating; then, when the laser is  
329 switched off (5.3 s), it drops down rapidly by a certain step and  
330 then rises again. For the 1 mm thick sample, the signal in a few  
331 seconds after the laser switch-off stabilizes at maximum value.  
332 For the 2 mm thick sample, it rises for a much longer time.  
333 This is explained by the following hypothesis: The drop after  
334 the laser switch-off is the signal from the interface, where the  
335 temperature rapidly decreases when the laser is switched off.  
336 The rest of the signal is from the surface of the semitransparent  
337 material, where the temperature still rises due to heat conduc-  
338 tion through the polymer. For lower thickness, the surface tem-  
339 perature stabilizes in a shorter time due to shorter distance from  
340 the heat source and lower heat capacity. The temperatures of  
341 the surface measured by the LWIR camera at the end of laser  
342 heating are 84°C and 45°C for 1 mm and 2 mm thickness.

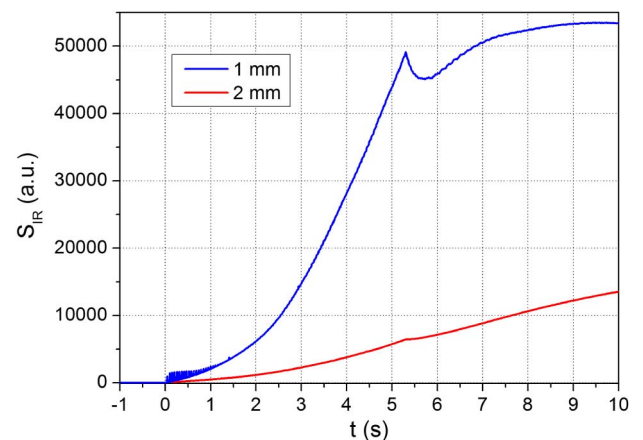
343 The IR signal from measurements with different optical fil-  
344 ters is shown in Figs. 9 and 10. The shape of the signal using  
345 the SP-2600 filter is very similar to the shape of the signal



**Fig. 7.** Thermal images of the weld from the MW/SWIR camera at the end of laser heating. (a) Without filter, POM 1 mm, integration time IT = 0.2 ms; (b) without filter, POM 2 mm, IT = 0.6 ms; (c) filter SP-2600, POM 1 mm, IT = 1.2 ms; (d) filter SP-3100, POM 1 mm, IT = 1.2 ms; (e) filter WG12012-C, POM 1 mm, IT = 1.2 ms. The L1 line (green) is shown in the figures.

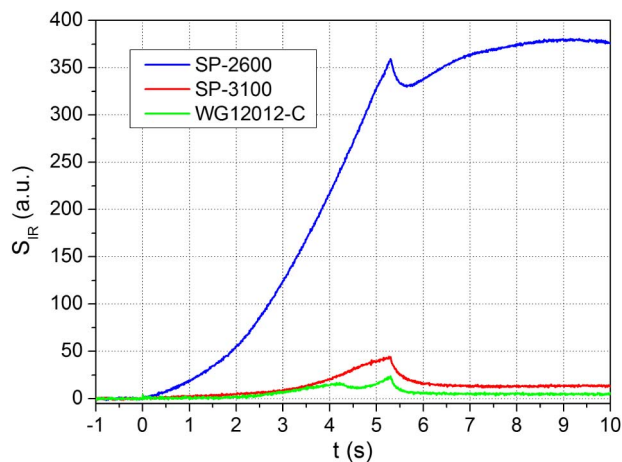
F7:1  
F7:2  
F7:3  
F7:4  
F7:5  
F7:6

346 without a filter. This can be explained by the presence of a  
347 transmission peak at 4.5  $\mu\text{m}$  wavelength for this filter, enabling  
348 radiation from the surface to be captured by the camera. The  
349 signals using filters SP-3100 and WG12012-C are different  
350 from the previously mentioned ones. After the end of laser

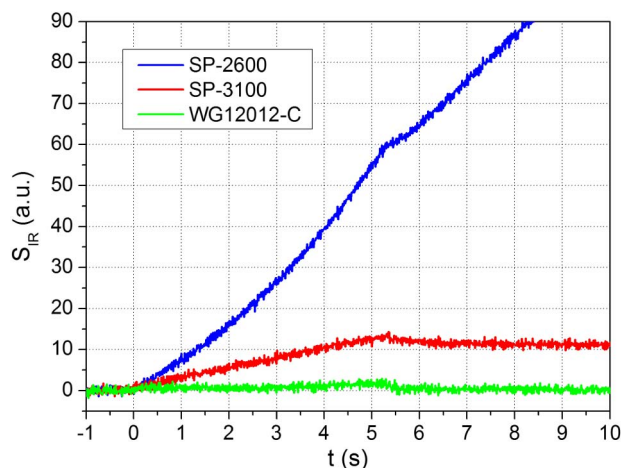


**Fig. 8.** Measured IR signal evolution over time from the MW/SWIR camera for two sample thicknesses.

F8:1  
F8:2



F9:1 **Fig. 9.** Measured IR signal evolution over time from the MW/  
F9:2 SWIR camera with different optical filters for sample thickness 1 mm.



F10:1 **Fig. 10.** Measured IR signal evolution over time from the MW/  
F10:2 SWIR camera with different optical filters for sample thickness 2 mm.

351 heating, there is no increase of the signal for these cases. This  
352 means that the signal from the surface is sufficiently decreased  
353 to be able to clearly observe the signal from the interface. On  
354 the other hand, the signal from the interface is very low and  
355 noisy. The stable value of the signal several seconds after the  
356 laser switch-off is supposed to be the signal from the surface,  
357 and so the signal from the interface is assumed to be only the  
358 resting difference between the signal peak at the end of laser  
359 heating and the mentioned stable value. The IR signal curve  
360 for the WG12012-C filter (1 mm thick sample) has a different  
361 shape because the process was done with higher laser power  
362 (45 W), but the signal at the end of laser heating should be  
363 at a good level for comparison with other signals (during  
364 the melt flow, the temperature is relatively stable).

365 From the measured IR signal evolutions over time, the signal  
366 contributions from the interface and surface at the end of laser  
367 heating (5.3 s) were determined. They are shown in Table 2.  
368 The surface IR signal for the SP-3100 and WG12012-C filters

**Table 2.** Measured IR Signal from the Surface of the Semitransparent Polymer and the Interface between Two Polymers for Different Filters at the End of Laser Heating

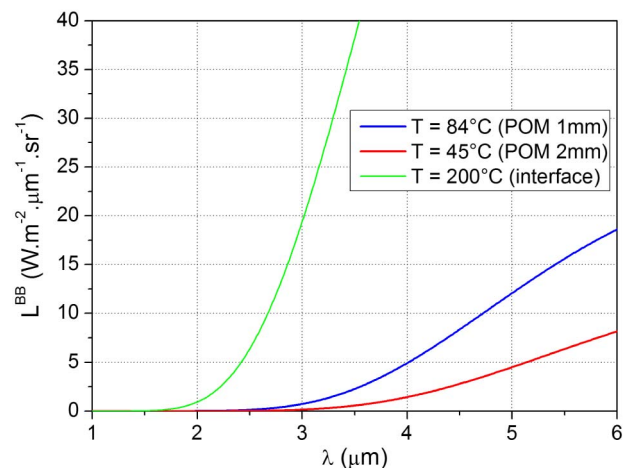
Optical Filter	IR Signal (a.u.)			
	POM 1 mm		POM 2 mm	
	Interface	Surface	Interface	Surface
–	6863.1	42134.2	667.9	5777.2
SP 2600	40.1	316.9	4.2	55.7
SP 3100	29.8	13.4	2.4	11.3
WG12012-C	17.7	5.1	1.4	0.3

369 was determined as an average over time from 7 to 10 s. The  
370 interface signal for these filters was determined as the value  
371 at the end of laser heating minus the surface signal. For the  
372 measurement without a filter and with the SP-2600 filter,  
373 the surface value is not clear. A linear fit was done over time  
374 from 6 to 6.5 s for the 1 mm thick sample (6.5 to 7 s for the  
375 2 mm thick sample), and its value at the end of the laser pulse  
376 (5.3 s) was said to be the surface signal. The interface signal  
377 for these measurements was determined as the value at the end  
378 of laser heating minus the surface signal. It can be seen that  
379 the signal from the interface is very low for the 2 mm sample  
380 thickness and when using optical filters. This can be due to  
381 significant scattering of the POM material and will be studied  
382 further in comparison with the calculation.

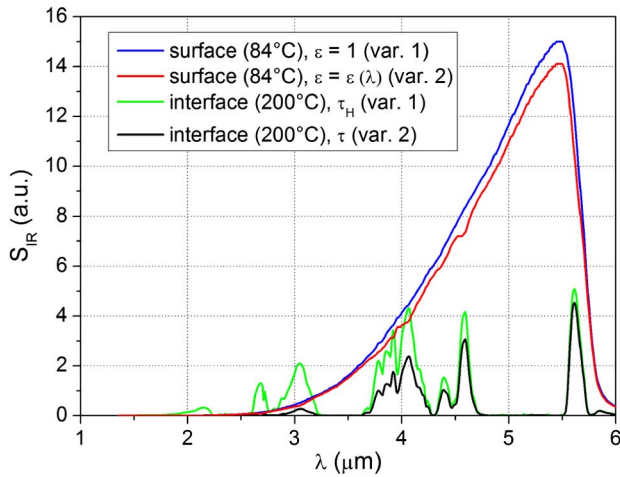
## B. Calculation Results

383 The first step in the calculation is calculation of radiation given  
384 by Planck's law. Spectral radiation intensity calculated for the  
385 interface and surface temperatures used in the calculation  
386 are shown in Fig. 11. In the SWIR range (transmissivity of optical  
387 filters used, from 1.5 to 2.7  $\mu\text{m}$ ), the interface emits  
388 significantly more radiation than the surface at lower temperature.  
389

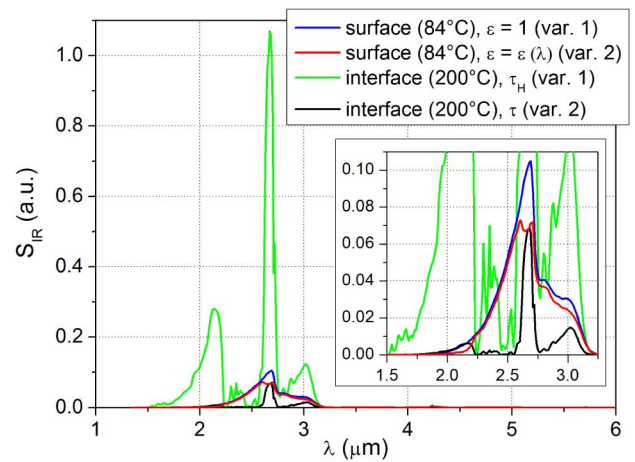
390 Spectral results of the calculation are shown in Figs. 12–15.  
391 The curves include all variables in Eqs. (2) and (3) inside of  
392 integrals and are shown for surface and interface, each with  
393 the two variants (Table 1). In the results without a filter



F11:1 **Fig. 11.** Spectral radiation intensity given by Planck's law for tem-  
F11:2 peratures used in the calculation: temperatures of the interface and  
F11:3 surfaces for two sample thicknesses.



F12:1 **Fig. 12.** Simulated spectral IR signal for measurement without a filter (different calculation variants).  
F12:2

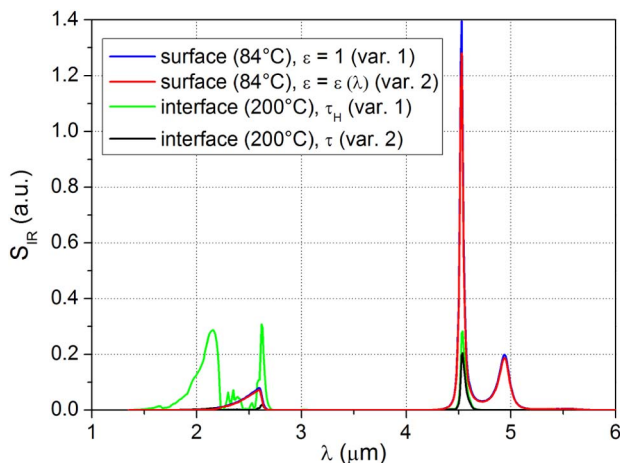


**Fig. 14.** Simulated spectral IR signal for measurement with the SP-3100 filter (different calculation variants).  
F14:1  
F14:2

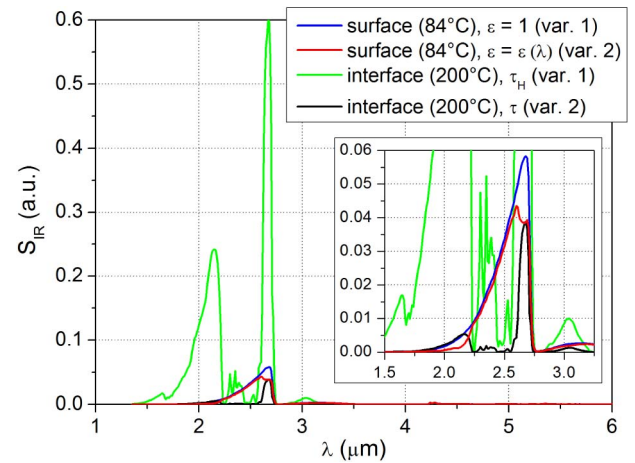
394 and with filter SP-2600, there is a high amount of radiation  
395 from the surface, due to measurement also on longer wave-  
396 lengths. For filters SP-3100 and WG12012-C, the radiation  
397 is restricted to shorter wavelengths up to 3.2 micrometers, as expected.  
398 The signal from the interface is present only in bands of  
399 transmissivity of the semitransparent polymer.

400 The influence of the type of transmissivity of the semitransparent  
401 polymer on the IR signal is very strong, mainly for the  
402 results with filters. The hemispherical transmissivity produces a  
403 high signal from the interface, much higher than the signal  
404 from the surface. For longer wavelengths, the influence of dif-  
405 ferent transmissivity is lower. The material is scattering the radi-  
406 ation less there. The signal for normal transmissivity and with  
407 filters is significantly lower than the signal from the surface,  
408 mainly outside of the transmission bands.

409 The influence of the emissivity is relatively low. The region  
410 of low emissivity (<1.7 micrometers) is outside of the region of emission  
411 at surface temperature. The bands of medium emissivity  
412 (1.7–2.2 micrometers and 2.6–2.73 micrometers) influence the emission  
413 from the surface, but not dramatically. In other wavelengths, the



F13:1 **Fig. 13.** Simulated spectral IR signal for measurement with the SP-  
F13:2 2600 filter (different calculation variants).



**Fig. 15.** Simulated spectral IR signal for measurement with the WG12012-C filter (different calculation variants).  
F15:1  
F15:2

emissivity is high, and so approximation of its value to 1 is  
appropriate at this level of simplification.

The simulated IR signal after integration is shown in Table 3 for the two variants. The signal was multiplied by 10,000 in order to obtain regular numbers. This can simulate amplification of the signal by the internal preamplifier of the camera. The signal without a filter is very strong (100 times higher) compared to the signal with optical filters. This is in accordance with measurement. The detailed comparison is presented in the next section.

### 5. COMPARISON OF CALCULATION WITH MEASUREMENT

The comparison of measurement and calculation was done for the time of the end of laser heating (5.3 s). At this time, the biggest signal is from the MW/SWIR camera for the filters SP-3100 and WG12012-C, and the highest temperature is at the molten interface. The comparison can be done only by ratio in

F14:1  
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**Table 3. Simulated IR Signal of the MW/SWIR Camera Received from the Interface and Surface for Different Calculation Variants and Sample Thicknesses**

		IR Signal (a.u.)			
Variant 1		POM 1 mm		POM 2 mm	
Optical Filter		Interface	Surface	Interface	Surface
-		31760.0	195180.0	2992.4	70436.0
SP 2600		1062.2	1293.4	339.2	409.2
SP 3100		1977.0	415.3	541.4	66.5
WG12012-C		1191.0	193.4	400.3	30.3
		IR signal (a.u.)			
Variant 2		POM 1 mm		POM 2 mm	
Optical Filter		Interface	Surface	Interface	Surface
-		17322.0	180350.0	774.7	66098.0
SP 2600		152.3	1182.2	8.4	383.3
SP 3100		109.2	347.2	8.6	61.1
WG12012-C		50.9	160.3	5.8	27.6

431 this case. Both measurement and calculation results are in ar-  
 432 bitrary units. The ratio of calculation to measurement in each  
 433 field of the table was selected for assessment of agreement of the  
 434 results. The ratio was then divided by 4 for normalization to  
 435 values around 1 for most fields. The normalized ratios are  
 436 shown in Table 4. The colors indicate the level of agreement  
 437 between measurement and calculation; green (the best) is from  
 438 1 to 1.5 or 1/1.5, yellow is to 2.5 or to 1/2.5, orange is to 5 or  
 439 to 1/5 and red (the worst) is for bigger or smaller values.

440 From the ratios, it can be seen that variant 2 gives better  
 441 agreement of calculation with measurement. The type of trans-  
 442 missivity significantly influences the agreement. Better agree-  
 443 ment is given by normal transmissivity—mainly for using  
 444 filters. For measurement without a filter, better results are with  
 445 hemispherical transmissivity. The emissivity does not change  
 446 the agreement significantly.

**Table 4. Normalized Ratio of Calculation to Measurement Results of the IR Signal of the MW/SWIR Camera Received from the Interface and Surface for Different Calculation Variants and Sample Thicknesses**

		Ratio of IR Signals (-)			
Variant 1		POM 1 mm		POM 2 mm	
Optical Filter		Interface	Surface	Interface	Surface
-		1.16	1.16	1.12	3.05
SP 2600		6.62	1.02	20.24	1.84
SP 3100		16.59	7.75	56.24	1.47
WG12012-C		16.87	9.53	73.42	25.07
		Ratio of IR signals (-)			
Variant 2		POM 1 mm		POM 2 mm	
Optical Filter		Interface	Surface	Interface	Surface
-		0.63	1.07	0.29	2.86
SP 2600		0.95	0.93	0.50	1.72
SP 3100		0.92	6.48	0.90	1.35
WG12012-C		0.72	7.90	1.06	22.83

**Table 5. Normalized Ratio of Calculation to Measurement Results of the Whole IR Signal of the MW/SWIR Camera Received from the Interface and Surface Together for Different Calculation Variants and Sample Thicknesses**

		Ratio of IR Signals (-)			
		Variant 1		Variant 2	
Optical Filter		POM 1 mm	POM 2 mm	POM 1 mm	POM 2 mm
-		0.93	2.28	0.81	2.08
SP 2600		1.32	2.50	0.75	1.31
SP 3100		11.08	8.87	2.11	1.02
WG12012-C		12.18	51.72	1.86	4.01

The biggest differences in variant 2 are for surface radiation with the WG12012-C filter for both thicknesses and with the SP-3100 filter with 1 mm thickness. The use of emissivity in the calculation decreased the difference, but only slightly.

Another comparison was done by comparing whole signals from measurement at the end of laser heating and the corresponding sum of the two signals from the calculation (interface + surface). This is shown in Table 5. In this case, the ratios were divided by 5 for normalization. Also in this case, variant 2 gives more consistent results than variant 1.

From the comparisons, it can be concluded that for measurement in SWIR wavelengths, the use of a normal value of transmissivity for the semitransparent polymer is more appropriate than the hemispherical value. Concerning selection of an appropriate optical filter, the best is use of filter SP-3100, because it does not transmit radiation from the surface (MWIR region), and it gives a bigger signal than filter WG12012-C.

In experiments with diffuse (scattering) materials in our laboratory, measurement of hemispherical transmissivity is usually performed, and so it was thought that it would be also appropriate for this case. For determination of emissivity of semitransparent (and diffuse) materials, the hemispherical transmissivity and reflectivity are essential. It was surprising that for the case of IR radiation emission measurement from the interface, the normal transmissivity is more appropriate.

For some materials, the difference between the normal and hemispherical transmissivity is negligible (e.g., PMMA), and there is no reason to distinguish between them. For POM material, the difference is strong (strong scattering), and it was found to be important to choose the normal transmissivity.

The physical explanation is that the camera senses radiation in one direction (narrow solid angle), and so the normal (directional) transmissivity is more appropriate.

Concerning wavelength, from the optical properties measurement (Fig. 3), it can be seen that for the POM sample, the significant scattering is only at the SWIR wavelengths, and in the MWIR wavelengths there is low or no scattering. It may be that this could be the reason for better results of comparison between the calculation and measurement for measurement without a filter, where the major part of the signal is in the MWIR wavelengths (Fig. 12).



The most important uncertainty in the calculation was expected to be the temperature of the interface, but from the comparison of the calculation with measurement, the biggest difference is in the signal from the surface for use of the SP-3100 and WG12012-C filters. We are not able to explain the low signal from the surface in the measurement obtained with the filter WG12012-C. There can also be influences of experimental uncertainties, because the camera signal is very low and noisy for these cases.

The experimental IR measurement uncertainty of the system based on an MW/SWIR camera can be indicated by signal noise and an uncertainty of the camera. The noise of the MW/SWIR camera at the 1.2 ms integration time is  $\pm 0.8$  a.u. (standard deviation, signal averaged over the line L1). The temperature measurement accuracy of the MW/SWIR camera (from datasheet) is  $\pm 1^\circ\text{C}$  or  $\pm 1\%$  of the measured value (the higher value is valid). From experimental data with the SP-2600 filter, it was deduced that  $\pm 1^\circ\text{C}$  equals to  $\pm 156$  a.u. This is significantly higher than most of the measured values, so the evaluated ratios can be significantly influenced by the accuracy of the camera. The relative manner of the measurement (difference to the signal corresponding to room conditions before laser welding) should minimize this influence.

Although the calculation is simple (e.g., not accounting for emission from the semitransparent sample interior, only from surface), the results are in reasonable correlation with measurements. The hypothesis regarding distinguishing signals from the surface and interface in measurement was confirmed. The calculation of the emission of IR radiation from different depths of the semitransparent sample is significantly more complicated due to different temperatures, transmissivities, and emissivities at different depths. This will be done in further research.

## 6. CONCLUSION

In the present work, a new measurement system and a new calculation of IR radiation were presented. It is a SWIR measurement system based on an MW/SWIR camera with an optical filter. The calculation is based on simplification of radiation sources to two places (interface and surface) and detailed knowledge of optical properties. The measurement system and calculation were applied to a quasi-simultaneous transmission laser welding of plastics.

In the measurement system, three different optical filters were used. During analysis using optical properties measurement, measurement of the welding process, and calculation, it was found that the most suitable is the SP-3100 filter, which has no transmission for higher wavelengths than  $3.2\ \mu\text{m}$  (as has filter SP-2600) and gives a higher signal from the interface than the WG12012-C filter.

In the calculation, the use of normal and hemispherical transmissivity of the semitransparent polymer and the use of constant emissivity and known measured emissivity of the semitransparent sample surface were compared. The calculation with normal transmissivity was in good agreement with the measurement for overall measurements, while hemispherical transmissivity gave good results only for measurement without a filter. This result was not expected, although the physical

explanation is simple. The use of known emissivity improved the agreement of the calculation with measurement, but the influence was rather minor.

From the results, it can be concluded that the proposed measurement system with the SP-3100 filter is a suitable system for analysis of thermal processes during quasi-simultaneous laser welding of plastics. Its suitability for polymer composites and process control will be analyzed in further steps. The calculation presented has proven to be useful and gives good agreement with measurement, although it is relatively simple. The normal transmissivity has been shown to be a good value to be used for the presented measurement system, while the hemispherical transmissivity did not give good results for the presently studied POM polymer. In further research, the calculation will be used to predict IR signal evolution over time during and after the process, in combination with numerical modeling of temperatures in the samples.

**Funding.** Ministerstvo Školství, Mládeže a Tělovýchovy (MŠMT) (CZ.1.05/2.1.00/03.0088; LO1402); Bayerisches Staatsministerium für Wirtschaft und Medien, Energie und Technologie; Ministerstvo pro místní rozvoj České Republiky.

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1. AU: In the sentence beginning “For these wavelengths,” are my changes OK? Have I retained your meaning?
2. AU: In the sentence beginning “The results are shown in,” does “a.u.” stand for “atomic units” or “arbitrary units?” Please spell out.
3. AU: In the sentence beginning “The spectral normal transmissivity  $\tau$ ,” please spell out “FTIR”.
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